

Search Notes



Application/Control No.

10/824,510

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under Reexamination

IMS ET AL.

Art Unit

2187

SEARCHED

Class	Subclass	Date	Examiner
711	106	Text search using EAST 5/30/06 H2	
	141		
	118		
707	201		
709	203		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG-PUB	Text	search 5/30/06 H2	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
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